

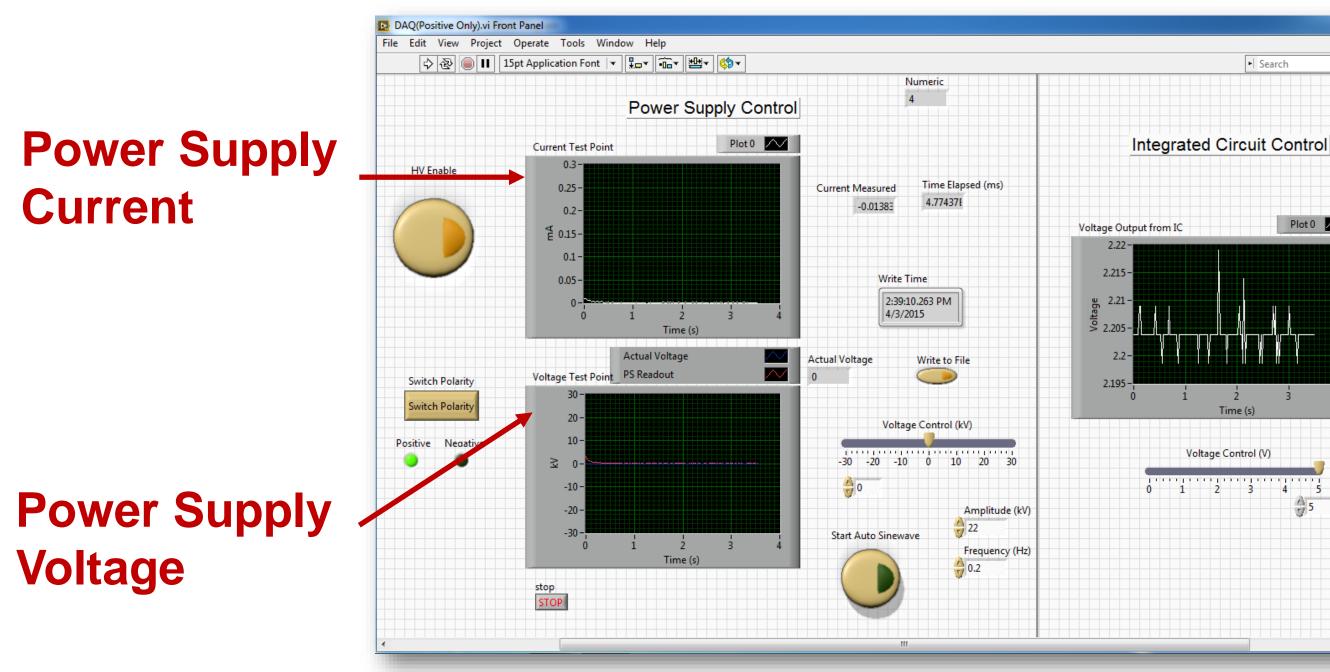
Background

- Space debris de-spin using Coulomb forces modeled in lab with charged sphere and cylinder
- Sphere and cylinder charged between +/- 30 kV
- Magnetic encoder measuring angle of cylinder is destroyed in presence of strong electric fields
- Expensive component to replace

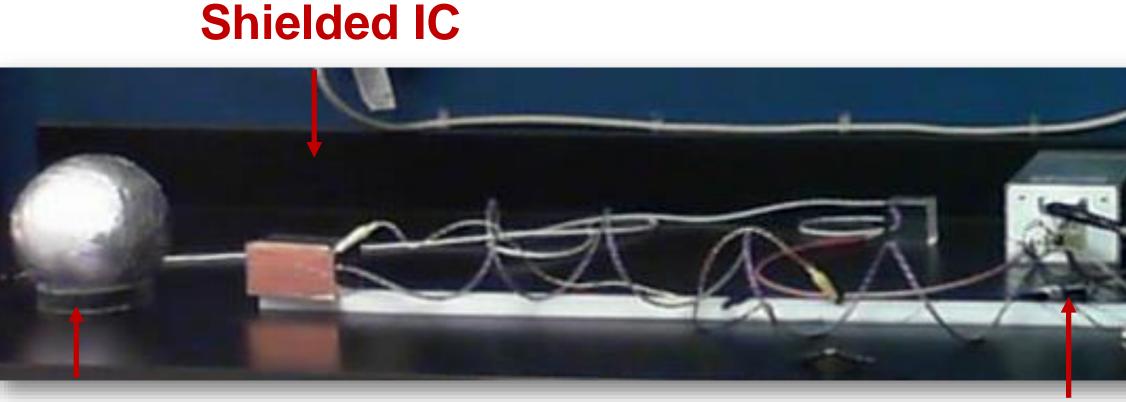
Electrostatic/dynamic shielding is necessary to protect electronic components in high voltage test beds

Experimental Setup

- Power supply controlled using LabView
- Integrated Circuit (IC) controlled using LabView
- Oscilloscope used to measure when DAQ (data acquisition) fails
- Representative of lab model **NOT** space environment



LabView VI for Power Supply and IC



Charged Sphere

Electromagnetic Interference in Strong Electric Fields



Numeric 2 2.2038

▶ Search

┟╷╾╷╷╹┰╵╢╴╖╵╢╵╽╴╴



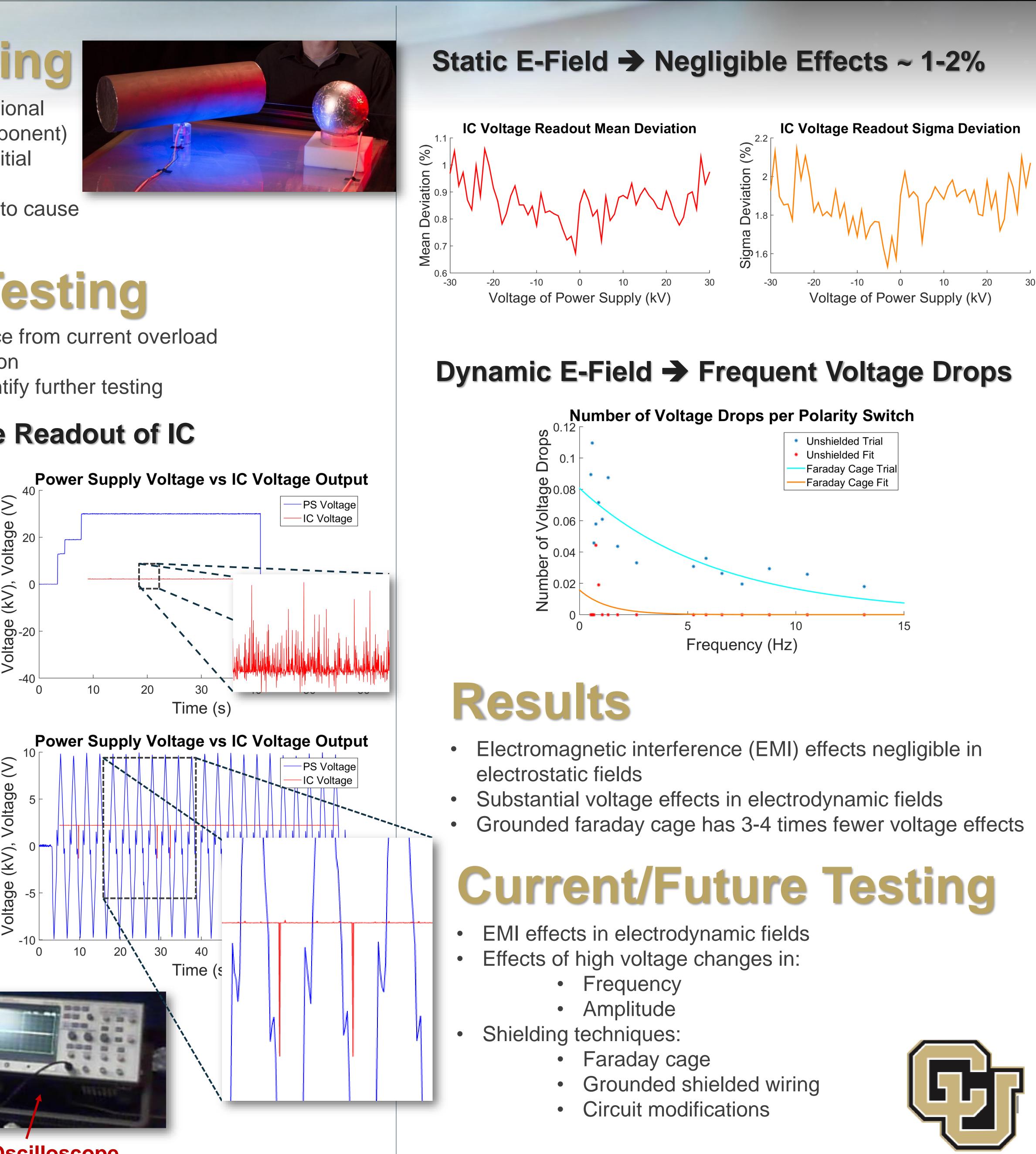
- IC used is a dual operational amplifier (common component)
- Used oscilloscope for initial shielding trials
- Found dynamic E-Field to cause interference

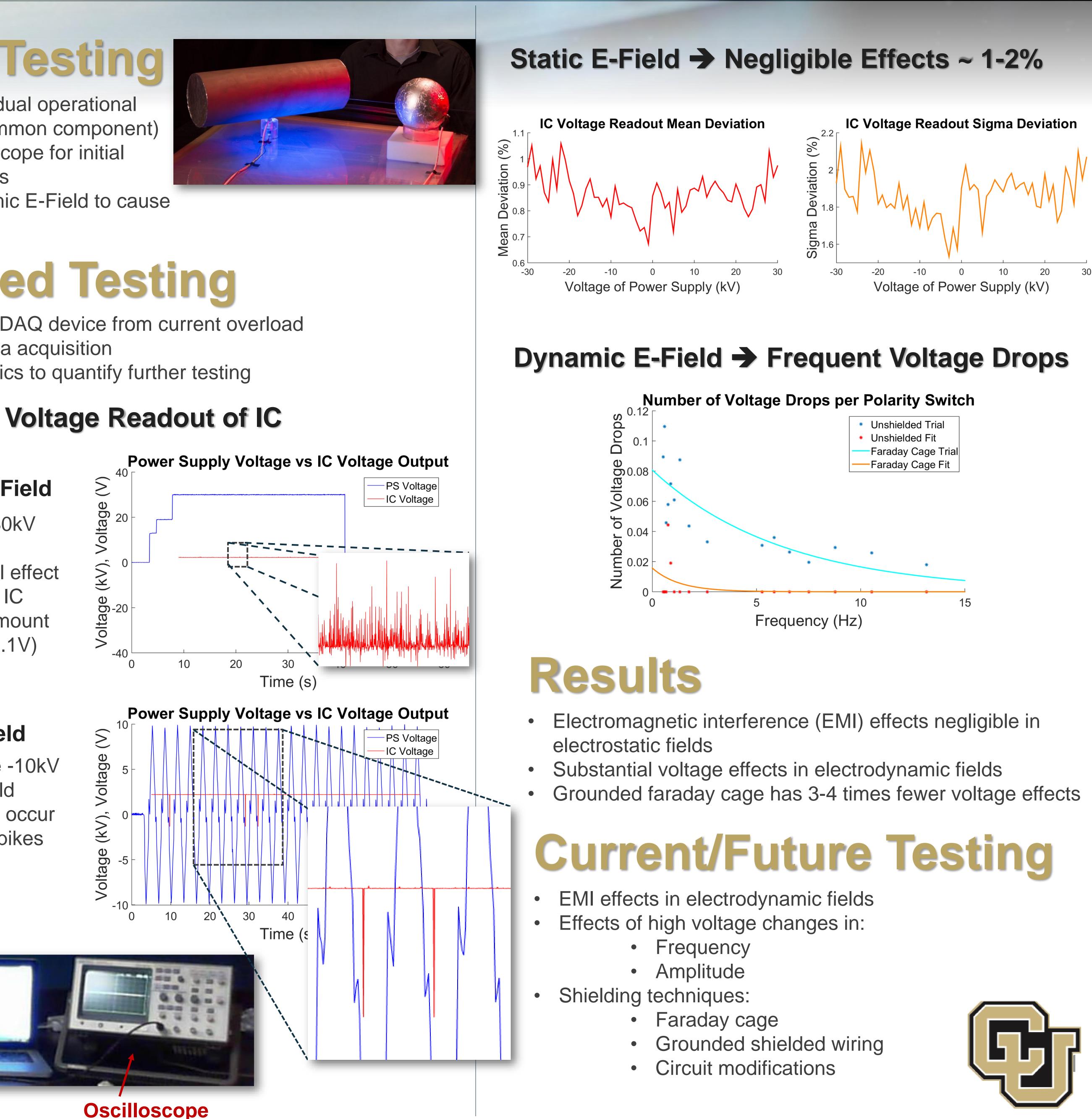
Modified Testing

- Protected IC DAQ device from current overload
- Real time data acquisition
- Created metrics to quantify further testing

Static 30kV E-Field

- Unchanging 30kV E-Field
- No substantial effect on function of IC
- Acceptable amount of noise (+/- 0.1V)





Dynamic E-Field

- Triangle wave -10kV to 10kV E-Field
- Voltage drops occur with current spikes

LabView

Control

IC Voltage Readout

DAQ



Steven Pfeifer Dr. Hanspeter Schaub Dr. Daan Stevenson **Trevor Bennett Joseph Hughes**